

**International Journal of Current
Microbiology and Applied Sciences
(IJCMAS) NAAS RATING-5.38, ICV-95.39**
ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)

An International, Monthly, Online, Free Access, Peer Reviewed,
Indexed, fast track Scientific Research Journal

Certificate of Publication

This is to certify that the following article reviewed by editorial board and published in International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2020.9.(6):1546-1556

<https://doi.org/10.20546/ijcmas.2020.906.191>

Study on Genetic Effect of Yield and Related Traits through Generation Mean Analysis in Wheat (Triticum aestivum L.)

Shivang Sharma* and Ajay Prakash Agrawal

Department of Genetics and Plant Breeding, BTC CARS, Bilaspur (C.G.), India



Dr. M. Prakash
Editor-in-chief

International Journal of Current Microbiology and Applied Sciences

www.ijcmas.com

www.excellentpublishers.com



© International Journal of Current Microbiology and Applied
Sciences (IJCMAS)

www.excellentpublishers.com www.ijcmas.com